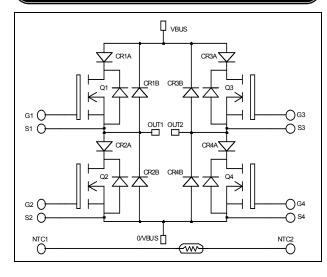
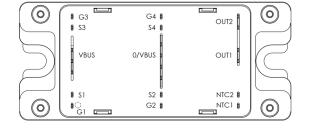


Full bridge Series & SiC parallel diodes MOSFET Power Module





$$\begin{split} V_{DSS} &= 500 V \\ R_{DSon} &= 75 m \Omega \text{ typ @ Tj} = 25^{\circ} C \\ I_D &= 46 A \text{ @ Tc} = 25^{\circ} C \end{split}$$

Application

- Motor control
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

Features

- Power MOS 7® MOSFETs
 - Low R_{DSon}
 - Low input and Miller capacitance
 - Low gate charge
 - Avalanche energy rated

• Parallel SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Kelvin source for easy drive
- Very low stray inductance
- Lead frames for power connections
- Internal thermistor for temperature monitoring
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

All ratings @ $T_j = 25$ °C unless otherwise specified

Absolute maximum ratings

| Symbol | Parameter | | Max ratings | Unit |
|--------------|---|---------------------|-------------|------|
| $V_{ m DSS}$ | Drain - Source Breakdown Voltage | | 500 | V |
| т | | $T_c = 25^{\circ}C$ | 46 | |
| I_{D} | | $T_c = 80$ °C | 34 | A |
| I_{DM} | Pulsed Drain current | | 184 | |
| V_{GS} | Gate - Source Voltage | | ±30 | V |
| R_{DSon} | Drain - Source ON Resistance | | 90 | mΩ |
| P_D | Maximum Power Dissipation | $T_c = 25^{\circ}C$ | 357 | W |
| I_{AR} | Avalanche current (repetitive and non repetitive) | | 46 | A |
| E_{AR} | Repetitive Avalanche Energy | | 50 | I |
| E_{AS} | Single Pulse Avalanche Energy | | 2500 | mJ |

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www microsemi com

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Electrical Characteristics

| Symbol | Characteristic | Test Conditions | Min | Тур | Max | Unit |
|---------------------|---------------------------------|---|-----|-----|------|------|
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{GS} = 0V, V_{DS} = 500V$ $T_j = 25^{\circ}C$ | | | 100 | μΑ |
| | | $V_{GS} = 0V, V_{DS} = 400V$ $T_j = 125^{\circ}C$ | ; | | 500 | |
| R _{DS(on)} | Drain – Source on Resistance | $V_{GS} = 10V, I_D = 23A$ | | 75 | 90 | mΩ |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS} = V_{DS}$, $I_D = 2.5 \text{mA}$ | 3 | | 5 | V |
| I_{GSS} | Gate – Source Leakage Current | $V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$ | | | ±100 | nA |

Dynamic Characteristics

| Symbol | Characteristic | Test Conditions | Min | Typ | Max | Unit |
|-----------------------------|-------------------------------------|---|-----|------|------|------|
| C_{iss} | Input Capacitance | $V_{GS} = 0V$ | | 5590 | | |
| C_{oss} | Output Capacitance | $V_{\rm DS} = 25V$ | | 1180 | | pF |
| C_{rss} | Reverse Transfer Capacitance | f=1MHz | | 85 | | |
| Q_{g} | Total gate Charge | $V_{GS} = 10V$ | | 123 | | |
| Q_{gs} | Gate – Source Charge | $V_{\text{Bus}} = 250V$ | | 33 | | nC |
| Q_{gd} | Gate – Drain Charge | $I_D = 46A$ | | 65 | | |
| $T_{d(on)}$ | Turn-on Delay Time | Inductive switching @ 125°C $V_{GS} = 15V$ $V_{Bus} = 333V$ $I_D = 46A$ $R_G = 5\Omega$ | | 18 | | |
| $T_{\rm r}$ | Rise Time | | | 35 | | |
| $T_{d(off)}$ | Turn-off Delay Time | | | 87 | | ns |
| T_{f} | Fall Time | | | 77 | | |
| Eon | Turn-on Switching Energy | Inductive switching @ 25°C | | 453 | | |
| $\mathrm{E}_{\mathrm{off}}$ | Turn-off Switching Energy | $V_{GS} = 15V, V_{Bus} = 333V$ $I_D = 46A, R_G = 5\Omega$ | | 726 | | μJ |
| Eon | Turn-on Switching Energy | Inductive switching @ 125°C $V_{GS} = 15V, V_{Bus} = 333V$ $I_D = 46A, R_G = 5\Omega$ | | 745 | | , |
| E _{off} | Turn-off Switching Energy | | | 846 | | μJ |
| R_{thJC} | Junction to Case Thermal Resistance | | | | 0.35 | °C/W |

Series diode ratings and characteristics

| Symbol | Characteristic Test Conditions | | Min | Typ | Max | Unit | |
|----------------------------|-------------------------------------|--|----------------------------------|------|-----|------|------|
| V_{RRM} | Peak Repetitive Reverse Voltage | | | | | 600 | V |
| I_{RM} | Reverse Leakage Current | $V_{R} = 600V$ | | | | 50 | μA |
| I_{F} | DC Forward current | | $Tc = 80^{\circ}C$ | | 50 | | A |
| W | D'. I. F I.W. Iv | $I_F = 50A$ $V_{GE} = 0V$ | $T_i = 25^{\circ}C$ | | 1.6 | 2 | V |
| V_{F} | Diode Forward Voltage | | $T_{i} = 150^{\circ}C$ | | 1.5 | | V |
| + | Reverse Recovery Time | | $T_j = 25$ °C | | 100 | | nc |
| t_{rr} | Reverse Recovery Time | | $T_{j} = 150^{\circ}C$ | | 150 | | ns |
| 0 | Reverse Recovery Charge | very Charge $I_F = 50A$ $V_R = 300V$ $di/dt = 1800A/\mu s$ | $T_j = 25$ °C | | 2.6 | | ııC |
| Q_{rr} | Reverse Recovery Charge | | $T_{j} = 150^{\circ}C$ | | 5.4 | | μС |
| Г | ' | $T_i = 25^{\circ}C$ | | 0.60 | | | |
| E_{rr} | Reverse Recovery Energy | | $T_{\rm j} = 150^{\circ}{\rm C}$ | | 1.2 | | mJ |
| R_{thJC} | Junction to Case Thermal Resistance | | | | | 1.42 | °C/W |

2 - 8



Parallel diode ratings and characteristics

| Symbol | Characteristic | Test Conditions | | Min | Typ | Max | Unit |
|------------------|-------------------------------------|--|--|-----|-----|-------------|------|
| V_{RRM} | Peak Repetitive Reverse Voltage | | | | | 600 | V |
| I_{RM} | Reverse Leakage Current | V _R =600V | $T_{j} = 25^{\circ}C$ $T_{i} = 175^{\circ}C$ | | 100 | 400 2000 | μΑ |
| I_{F} | DC Forward Current | | $Tc = 125^{\circ}C$ | | 20 | 2000 | Α |
| V_{F} | Diode Forward Voltage | $I_F = 20A$ | $T_i = 25^{\circ}C$ $T_j = 175^{\circ}C$ | | 1.6 | 1.8 | V |
| Qc | Total Capacitive Charge | $I_F = 20A, V_R = 600V$ di/dt = 800A/ μ s | | | 56 | | nC |
| | Total Compaitance | $f = 1 MHz, V_R = 200V$ | | 130 | 130 | | ъE |
| Q | Total Capacitance | $f = 1MHz, V_R = 400V$ | | | 100 | | pF |
| R_{thJC} | Junction to Case Thermal Resistance | | | | | 1.5 | °C/W |

Thermal and package characteristics

| Symbol | Characteristic | | | Min | Max | Unit | |
|-------------|--|-------------|----|------|------------------------|------|--|
| V_{ISOL} | RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz | | | 4000 | | V | |
| T_{J} | Operating junction temperature range | | | -40 | 150 | | |
| T_{JOP} | Recommended junction temperature under switching conditions | | | -40 | T _J max -25 | °C | |
| T_{STG} | Storage Temperature Range | | | -40 | 125 | | |
| $T_{\rm C}$ | Operating Case Temperature | | | -40 | 100 | | |
| Torque | Mounting torque | To Heatsink | M5 | 2.5 | 4.7 | N.m | |
| Wt | Package Weight | | | | 160 | g | |

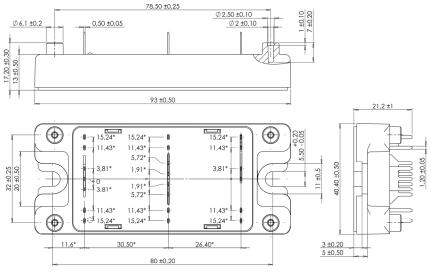
Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

| Symbol | Characteristic | | Min | Тур | Max | Unit |
|------------------------|-----------------------------|-----------------------|-----|------|-----|------|
| R ₂₅ | Resistance @ 25°C | | | 50 | | kΩ |
| $\Delta R_{25}/R_{25}$ | | | | 5 | | % |
| $B_{25/85}$ | $T_{25} = 298.15 \text{ K}$ | | | 3952 | | K |
| ΔΒ/Β | | T _C =100°C | | 4 | | % |

$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{-1}} - \frac{1}{T} \right) \right]}$$
 T: Thermistor temperature R_T: Thermistor value at T

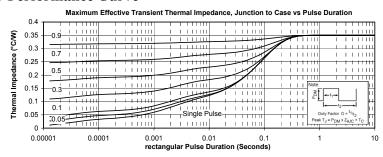


SP4 Package outline (dimensions in mm)

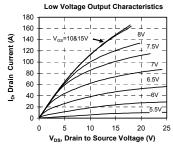


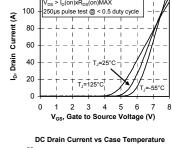
See application note APT0501 - Mounting Instructions for SP4 Power Modules on www.microsemi.com

Typical MOSFET Performance Curve

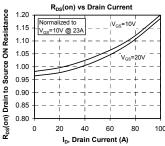


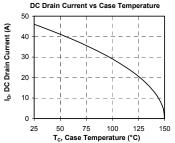
120





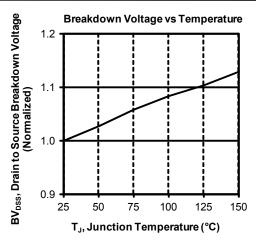
Transfert Characteristics

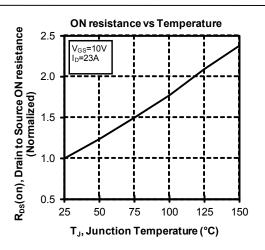


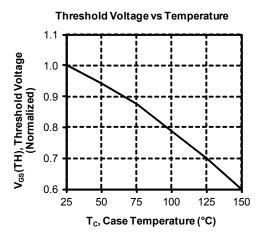


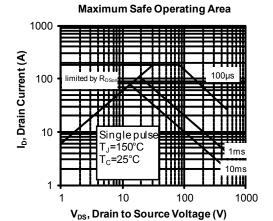
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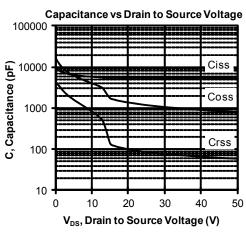


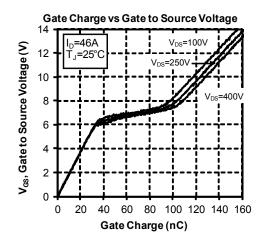




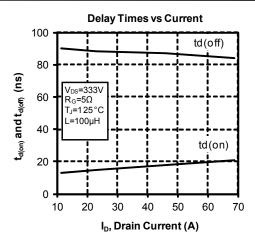


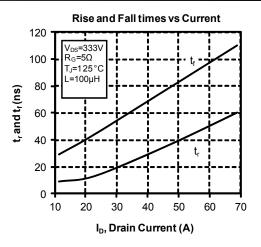


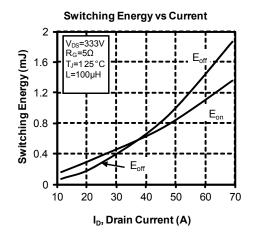


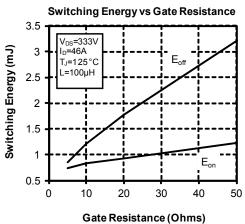


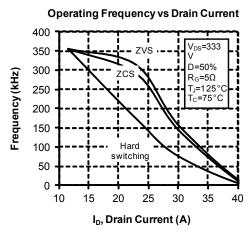


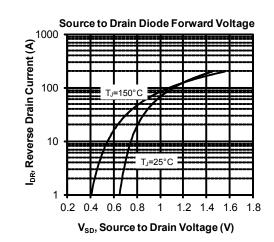






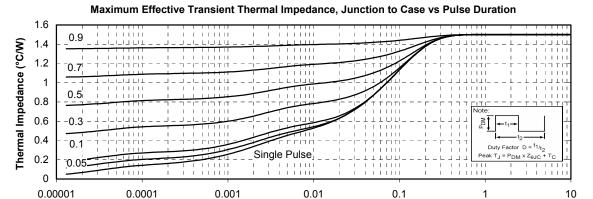




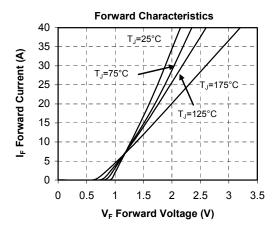


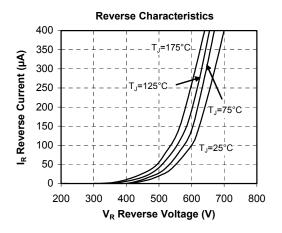


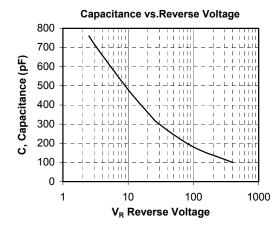
Typical SiC Diode Performance Curve



Rectangular Pulse Duration (Seconds)









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